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3rd Generation thinQ![™] SiC Schottky Diode

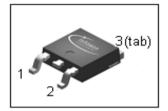
Features

- Revolutionary semiconductor material Silicon Carbide
- Switching behavior benchmark
- No reverse recovery / No forward recovery
- Temperature independent switching behavior
- High surge current capability
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹⁾ for target applications
- Breakdown voltage tested at 20mA²⁾
- · Optimized for high temperature operation
- Lowest Figure of Merit Q_C/I_F

Product Summary

$V_{ m DC}$	600	>
Q_C	6	nC
<i>I</i> _F ; <i>T</i> _C < 130 °C	5	Α

PG-T0252-3



thinQ! 3G Diode designed for fast switching applications like:

• SMPS e.g.; CCM PFC

· Motor Drives; Solar Applications; UPS





Туре	Package	Marking	Pin 1	Pin 2	Pin 3
IDD05SG60C	PG-TO252-3	D05G60C	n.c.	А	С

Maximum ratings

Parameter	Symbol	Conditions	Value	Unit
Continuous forward current	I _F	T _C <130 °C	5	Α
Surge non-repetitive forward current,	I _{F,SM}	$T_{\rm C}$ =25 °C, $t_{\rm p}$ =10 ms	26	
sine halfwave		$T_{\rm C}$ =150 °C, $t_{\rm p}$ =10 ms	18	
Non-repetitive peak forward current	I _{F,max}	$T_{\rm C}$ =25 °C, $t_{\rm p}$ =10 μs	150	
<i>i</i> ² <i>t</i> value	∫ <i>i</i> ²dt	$T_{\rm C}$ =25 °C, $t_{\rm p}$ =10 ms	3.2	A ² s
r-t value		$T_{\rm C}$ =150 °C, $t_{\rm p}$ =10 ms	2	
Repetitive peak reverse voltage	V_{RRM}	<i>T</i> _j =25 °C	600	V
Diode dv/dt ruggedness	d <i>v</i> ∕d <i>t</i>	V _R = 0480 V	50	V/ns
Power dissipation	P_{tot}	T _C =25 °C	56	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$		-55 175	°C
Soldering temperature, reflow soldering (max)	T_{sold}	reflow MSL1	260	



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}		1	1	2.7	K/W
Thermal resistance, junction -	R_{thJA}	SMD version, device on PCB, minimal footprint	•	-	75	
ambient		SMD version, device on PCB, 6 cm ² cooling area ⁵⁾	1	50	1	

Electrical characteristics, at T_i =25 °C, unless otherwise specified

Static characteristics

DC blocking voltage	V_{DC}	I_{R} =0.05 mA, T_{j} =25 °C	600	-	-	٧
Diode forward voltage	V _F	I _F =5 A, T _j =25 °C	-	2.1	2.3	
		I _F =5 A, T _j =150 °C	-	2.8	-	
Reverse current	I _R	V _R =600 V, T _j =25 °C	-	0.4	30	μΑ
		V _R =600 V, T _j =150 °C	-	1.5	350	1

AC characteristics

Total capacitive charge	Q_{c}	V_{R} =400 V, I_{F} ≤ $I_{F,max}$, d i_{F} /d t =200 A/ μ s,	-	6	-	nC
Switching time ³⁾	t_c	$T_j=150 ^{\circ}\text{C}$	1	1	<10	ns
Total capacitance	С	V _R =1 V, <i>f</i> =1 MHz	-	110	-	pF
		V _R =300 V, f=1 MHz	-	15	-	
		V _R =600 V, f=1 MHz	-	15	-	

¹⁾ J-STD20 and JESD22

²⁾ All devices tested under avalanche conditions, for a time periode of 10ms, at 20mA.

 $^{^{3)}}$ t_c is the time constant for the capacitive displacement current waveform (independent from T_j , I_{LOAD} and di/dt), different from t_{rr} which is dependent on T_j , I_{LOAD} and di/dt. No reverse recovery time constant t_{rr} due to absence of minority carrier injection.

⁴⁾ Under worst case Z_{th} conditions.

⁵⁾ Device on 40mm*40mm*1.5 epoxy PCB FR4 with 6cm² (one layer, 70μm thick) copper area for drain connection. PCB is vertical without blown air

⁶⁾ Only capacitive charge occuring, guaranteed by design.

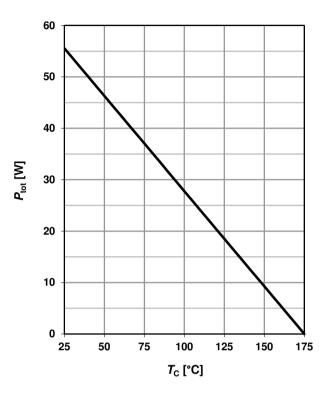


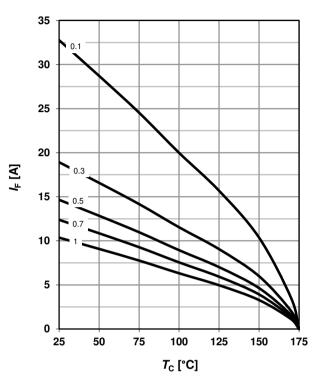
1 Power dissipation

 $P_{\text{tot}} = f(T_{\text{C}})$; parameter: $R_{\text{thJC(max)}}$

2 Diode forward current

 $I_F = f(T_C)^{4}$; $T_i \le 175$ °C; parameter: $D = t_p/T$



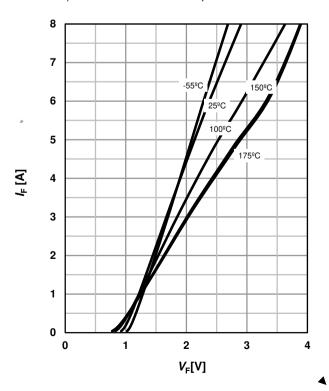


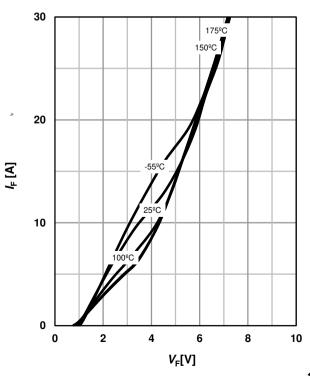
3 Typ. forward characteristic

 $I_F = f(V_F)$; $t_p = 400 \mu s$; parameter: T_i

4 Typ. forward characteristic in surge current mode

 I_F =f(V_F); t_p =400 μs; parameter: T_j





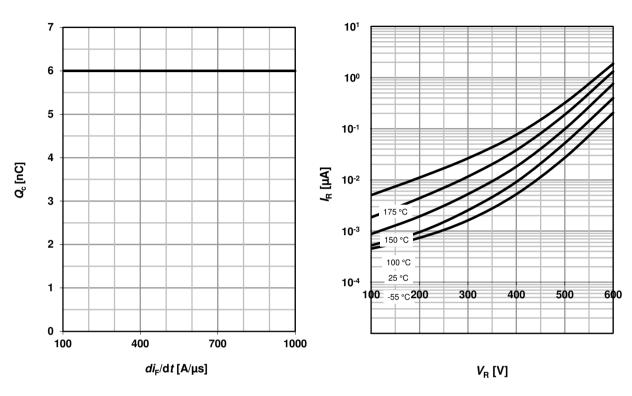


5 Typ. capacitance charge vs. current slope

$Q_{C}=f(di_{F}/dt)^{6}$; $I_{F} \leq I_{F,max}$

6 Typ. reverse current vs. reverse voltage

$$I_R=f(V_R)$$
; parameter: T_i

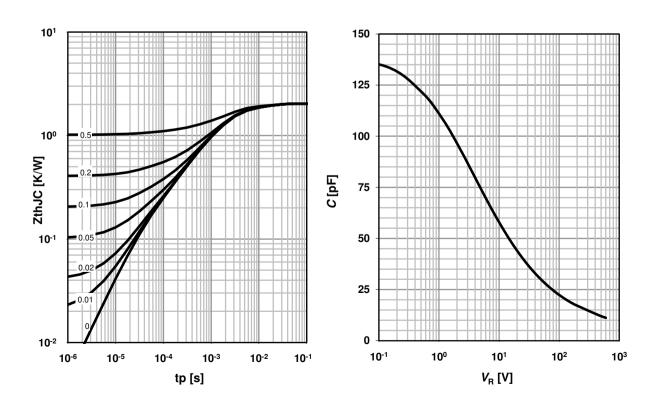


7 Transient thermal impedance

 Z_{thJC} =f(t_p); parameter: $D = t_P/T$

8 Typ. capacitance vs. reverse voltage

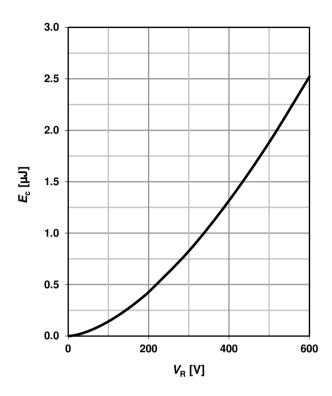
$$C=f(V_R)$$
; $T_C=25$ °C, $f=1$ MHz





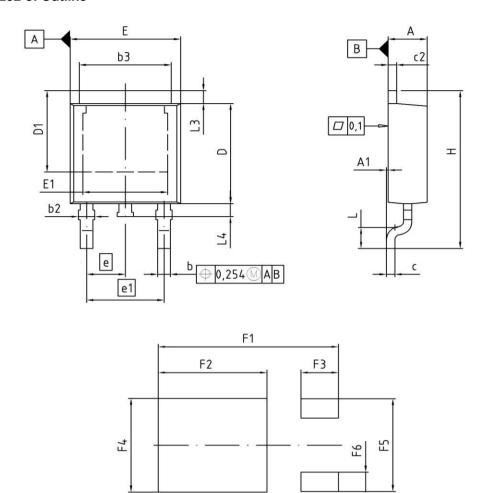
9 Typ. C stored energy

 $E_{C}=f(V_{R})$





PG-TO252-3: Outline



DIM	MILLIM	IETERS	INCH	HES	
DIM	MIN	MAX	MIN	MAX	
Α	2.16	2.41	0.085	0.095	
A1	0.00	0.15	0.000	0.006	
Ь	0.64	0.89	0.025	0.035	
b2	0.65	1.15	0.026	0.045	
ь3	5.00	5.50	0.197	0.217	
С	0.46	0.60	0.018	0.024	
c2	0.46	0.98	0.018	0.039	
D	5.97	6.22	0.235	0.245	
D1	5.02	5.84	0.198	0.230	
Ε	6.40	6.73	0.252	0.265	
E1	4.70	5.21	0.185	0.205	
е	2	2.29		0.090	
e1	4	.57	0.1	180	
N		3		3	
Н	9.40	10.48	0.370	0.413	
L	1.18	1.70	0.046	0.067	
L3	0.90	1.25	0.035	0.049	
L4	0.51	1.00	0.020	0.039	
F1	10.50	10.70	0.413	0.421	
F2	6.30	6.50	0.248	0.256	
F3	2.10	2.30	0.083	0.091	
F4	5.70	5.90	0.224	0.232	
F5	5.66	5.86	0.223	0.231	
F6	1.10	1.30	0.043	0.051	

DOCUMENT NO. Z8B00003328
SCALE 0-
2.0-3 0 2.0 14mm
EUROPEAN PROJECTION
ISSUE DATE 19-10-2007
REVISION 03

Dimensions in mm/inches



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